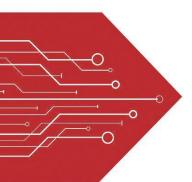
MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

Product data sheet

www.msksemi.com



Mechanical Characteristics

◆ Package: SOD-323 ◆ Lead Finish: Matte Tin

◆ Case Material: "Green" Molding Compound. ◆ UL Flammability Classification Rating 94V-0 ♦ Moisture Sensitivity: Level 3 per J-STD-020 ◆ Terminal Connections: See Diagram Below Marking Information: See Below

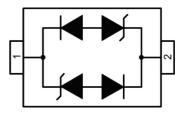
Applications

- USB Ports
- Smart Phones
- Wireless Systems
- ◆ Ethernet 10/100/1000 Base T

Features

- ◆ 350W peak pulse power (8/20µs)
- ◆ Ultra low capacitance: 1.0pF typical
- Ultra low leakage: nA level
- ◆ Low Operating: 3.3V,5V,8V,12V,15V,24V
- Low clamping voltage
- Protects one power line or data line
- Complies with following standards:
 - IEC 61000-4-2 (ESD) immunity test Air discharge: ±30kV Contact discharge: ±30kV - IEC61000-4-4 (EFT) 40A (5/50ns)
- ◆ RoHS Compliant

Dimensions and Pin Configuration



Circuit and Pin Schematic

SOD-323

Absolute Maximum Ratings (T_A=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit	
ESD per IEC 61000-4-2 (Air)	\/ E OD	±30	14) /	
ESD per IEC 61000-4-2 (Contact)	VESD	±30	kV	
Operating Temperature Range	TJ	-40 to +85	°C	
Storage Temperature Range	Tstg	−55 to +150	°C	



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Electrical Characteristics (T_{Δ} =25°C unless otherwise specified)

SPD9103W-MS						
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Reverse Working Voltage	VRWM			3.3	V	
Breakdown Voltage	VBR	4			V	IT = 1mA
Reverse Leakage Current	I _R		1	100	nA	VRWM = 3.3V
Clamping Voltage	Vc			7	V	IPP = 1A (8 x 20μs pulse)
Clamping Voltage	Vc			16	V	IPP = 20A (8 x 20µs pulse)
Peak Pulse Current	IPP			20	А	tp=8/20µs
Junction Capacitance	Cı		1		pF	VR = 0V, f = 1MHz

SPD9105W-MS						
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Reverse Working Voltage	VRWM			5	V	
Breakdown Voltage	VBR	6			V	IT = 1mA
Reverse Leakage Current	I _R		1	100	nA	VRWM = 5V
Clamping Voltage	Vc			10	V	IPP = 1A (8 x 20µs pulse)
Clamping Voltage	Vc			18	V	IPP = 18A (8 x 20µs pulse)
Peak Pulse Current	IPP			18	Α	tp=8/20µs
Junction Capacitance	Cl		1		pF	VR = 0V, f = 1MHz



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SPD9108W-MS						
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition
Reverse Working Voltage	VRWM			8	V	
Breakdown Voltage	VBR	8.5			V	IT = 1mA
Reverse Leakage Current	I _R		1	100	nA	VRWM = 8V
Clamping Voltage	Vc			14	V	IPP = 1A (8 x 20µs pulse)
Clamping Voltage	Vc			19	V	IPP = 13A (8 x 20µs pulse)
Peak Pulse Current	IPP			13	Α	tp=8/20µs
Junction Capacitance	Cl		1		pF	VR = 0V, f = 1MHz

SPD9112W-MS							
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition	
Reverse Working Voltage	VRWM			12	V		
Breakdown Voltage	VBR	13.3			V	IT = 1mA	
Reverse Leakage Current	I _R		1	100	nA	VRWM = 12V	
Clamping Voltage	Vc			19	V	IPP = 1A (8 x 20μs pulse)	
Clamping Voltage	Vc			25	V	IPP = 10A (8 x 20µs pulse)	
Peak Pulse Current	IPP			10	Α	tp=8/20µs	
Junction Capacitance	Сл		1		pF	VR = 0V, f = 1MHz	







SPD9115W-MS							
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition	
Reverse Working Voltage	VRWM			15	V		
Breakdown Voltage	VBR	16.7			V	IT = 1mA	
Reverse Leakage Current	I _R		1	100	nA	VRWM = 15V	
Clamping Voltage	Vc			20	V	IPP = 1A (8 x 20μs pulse)	
Clamping Voltage	Vc			31	V	IPP = 8A (8 x 20μs pulse)	
Peak Pulse Current	IPP			8	А	tp=8/20µs	
Junction Capacitance	Cl		1		pF	VR = 0V, f = 1MHz	

SPD9124W-MS							
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition	
Reverse Working Voltage	VRWM			24	V		
Breakdown Voltage	VBR	26.7			V	IT = 1mA	
Reverse Leakage Current	I _R		1	100	nA	VRWM = 24V	
Clamping Voltage	Vc			40	V	IPP = 1A (8 x 20µs pulse)	
Clamping Voltage	Vc			71	V	IPP = 3.5A (8 x 20μs pulse)	
Peak Pulse Current	IPP			3.5	А	tp=8/20µs	
Junction Capacitance	Сл		1		pF	VR = 0V, f = 1MHz	







Symbol	Parameter
I _{PP}	Maximum Reverse Peak Pulse Current
Vc	Clamping Voltage @ IPP
V _{RWM}	Working Peak Reverse Voltage
I _R	Maximum Reverse Leakage Current @ V _{RWM}
I _T	Test Current
V_{BR}	Breakdown Voltage @ I⊤

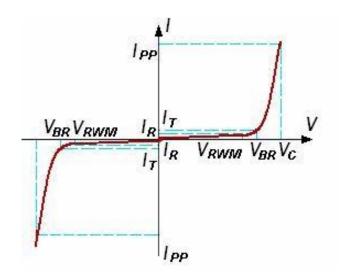


FIG1: Pulse Waveform

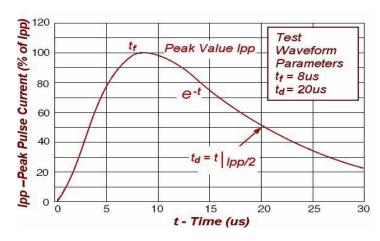
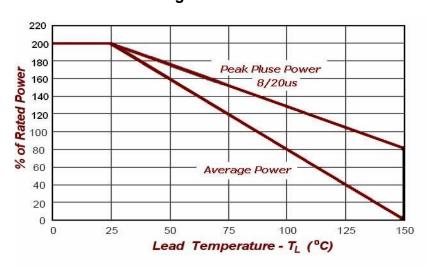
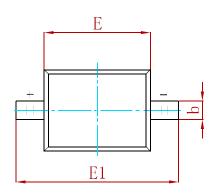


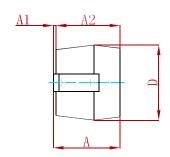
FIG2:Power Derating

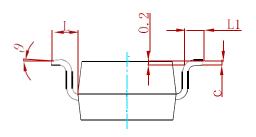






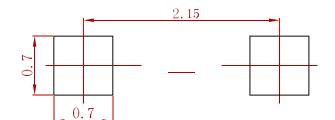






O	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α		1.000		0.039
A 1	0.000	0.100	0.000	0.004
A2	0.800	0.900	0.031	0.035
b	0.250	0.350	0.010	0.014
С	0.080	0.150	0.003	0.006
D	1.200	1.400	0.047	0.055
E	1.600	1.800	0.063	0.071
E1	2.550	2.750	0.100	0.108
L	0.475	REF.	0.019	REF.
L1	0.250	0.400	0.010	0.016
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
SPD91XXW-MS	SOD-323	3000

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